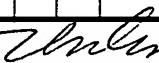
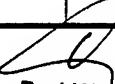


Issue Classification				Application/Control No.		Applicant(s)/Patent under Reexamination	
				10/812,890		JAPP ET AL.	
				Examiner		Art Unit	
				Thinh T. Nguyen		2818	

ORIGINAL				CROSS REFERENCE(S)									
CLASS		SUBCLASS		CLASS		SUBCLASS (ONE SUBCLASS PER BLOCK)							
257		762		257		762	760						
INTERNATIONAL CLASSIFICATION													
H	0	1	L	23/52									
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 Thinh T. Nguyen 01/2006				 David Nelms Supervisory Patent Examiner Technology Center 2800								Total Claims Allowed: 15	
 M. Geruson 16/04 (Legal Instruments Examiner) (Date)				(Primary Examiner) (Date) 								O.G. Print Claim(s) 1	O.G. Print Fig. FIG 6

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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